

# Automotive N- and P-Channel 40 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY						
	N-CHANNEL	P-CHANNEL				
V <sub>DS</sub> (V)	40	- 40				
$R_{DS(on)}(\Omega)$ at $V_{GS} = \pm 10 \text{ V}$	0.014	0.028				
$R_{DS(on)}(\Omega)$ at $V_{GS} = \pm 4.5 \text{ V}$	0.015	0.042				
I <sub>D</sub> (A)	8	- 8				
Configuration	N & P Pair					

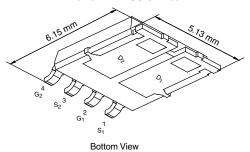
#### **FEATURES**

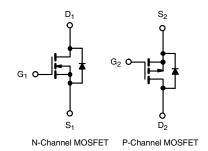
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- AEC-Q101 Qualified<sup>d</sup>
- Compliant to RoHS Directive 2002/95/EC





#### PowerPAK® SO-8L Dual





ORDERING INFORMATION	
Package	PowerPAK SO-8
Lead (Pb)-free and Halogen-free	SQJ500EP-T1-GE3

ABSOLUTE MAXIMUM RATINGS (To	= 25 °C, unless	otherwise n	oted)			
PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT		
Drain-Source Voltage	V <sub>DS</sub>	40	- 40			
Gate-Source Voltage		$V_{GS}$	± 20		V	
Continuous Drain Current <sup>a</sup>	T <sub>C</sub> = 25 °C	I <sub>D</sub>	8	- 8		
Continuous Drain Current	T <sub>C</sub> = 125 °C		8	- 8		
Continuous Source Current (Diode Conduction) <sup>a</sup>	I <sub>S</sub>	8	- 8	Α		
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	32	- 32		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	30	- 30		
Single Pulse Avalanche Energy	L = 0.1 IIII	E <sub>AS</sub>	45	45	mJ	
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	В	48	48	w	
Maximum Fower Dissipation	T <sub>C</sub> = 125 °C	$P_{D}$	16	16		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175		°C	
Soldering Recommendations (Peak Temperature) <sup>e, f</sup>			260			

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT			
Junction-to-Ambient	PCB Mount <sup>c</sup>	$R_{thJA}$	85	85	°C/W		
Junction-to-Case (Drain)		$R_{thJC}$	3.1	3.1	G/VV		

### Notes

- a. Package limited.
- b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- c. When mounted on 1" square PCB (FR4 material).
- d. Parametric verification ongoing.
- e. See solder profile (<a href="https://www.vishay.com/ppg?73257">www.vishay.com/ppg?73257</a>). The PowerPAK SO-8L. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- f. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.



PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNIT
Static		1			l			
Davis Os and David de a Walles	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		N-Ch	40	-	-	- v
Drain-Source Breakdown Voltage		V <sub>GS</sub> =	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA		- 40	-	-	
	.,	$V_{DS} = V_{GS}, I_D = 250 \mu A$		N-Ch	1.5	2	2.5	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	P-Ch	- 1.5	- 2	- 2.5	
Cata Saurea Laglaga				N-Ch	-	-	± 100	A
Gate-Source Leakage	I <sub>GSS</sub>	v <sub>DS</sub> =	$0 \text{ V}, \text{ V}_{GS} = \pm 20 \text{ V}$	P-Ch	-	-	± 100	nA
		$V_{GS} = 0 V$	V <sub>DS</sub> = 40 V	N-Ch	-	-	1	
		V <sub>GS</sub> = 0 V	V <sub>DS</sub> = - 40 V	P-Ch	-	-	- 1	
Zana Oala Wallana Buria Oanad		V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 40 V, T <sub>J</sub> = 125 °C	N-Ch	-	-	50	1
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = - 40 V, T <sub>J</sub> = 125 °C	P-Ch	-	-	- 50	μA
		V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 40 V, T <sub>J</sub> = 175 °C	N-Ch	-	-	150	=
		V <sub>GS</sub> = 0 V	V <sub>DS</sub> = - 40 V, T <sub>J</sub> = 175 °C	P-Ch	-	-	- 150	
	I <sub>D(on)</sub>	V <sub>GS</sub> = 10 V	$V_{DS} \ge 5 \text{ V}$	N-Ch	25	-	-	А
On-State Drain Current <sup>a</sup>		V <sub>GS</sub> = - 10 V	V <sub>DS</sub> ≤ 5 V	P-Ch	- 25	-	-	
		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 8 A	N-Ch	-	0.011	0.014	Ω
	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 8 A	P-Ch	-	0.022	0.028	
		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 8 A, T <sub>J</sub> = 125 °C	N-Ch	-	-	0.017	
		V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 8 A, T <sub>J</sub> = 125 °C	P-Ch	-	-	0.041	
Drain-Source On-State Resistance <sup>a</sup>		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 8 A, T <sub>J</sub> = 175 °C	N-Ch	-	-	0.025	
		V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 8 A, T <sub>J</sub> = 175 °C	P-Ch	-	-	0.049	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 6 A	N-Ch	-	0.012	0.015	
		V <sub>GS</sub> = - 4.5 V	I <sub>D</sub> = - 6 A	P-Ch	-	0.033	0.042	
		$V_{DS}$	= 15 V, I <sub>D</sub> = 8 A	N-Ch	-	40	-	
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	V <sub>DS</sub> =	P-Ch	-	18	-	S	
Dynamic <sup>b</sup>		1		L	l			
		V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 20 V, f = 1 MHz	N-Ch	_	1799	2248	
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = - 20 V, f = 1 MHz	P-Ch	-	1756	2195	
	_	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 20 V, f = 1 MHz	N-Ch	-	282	352	1 _
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = - 20 V, f = 1 MHz	P-Ch	-	296	370	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 20 V, f = 1 MHz	N-Ch	-	109	136	1
		V <sub>GS</sub> = 0 V	V <sub>DS</sub> = - 20 V, f = 1 MHz	P-Ch	-	208	260	
Total Gate Charge <sup>c</sup>	Qg	V <sub>GS</sub> = 10 V	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 10 A	N-Ch	-	31.5	48	
		V <sub>GS</sub> = - 10 V	V <sub>DS</sub> = - 20 V, I <sub>D</sub> = - 10 A	P-Ch	-	41.5	63	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 10 A	N-Ch	-	5.7	-	nC
		V <sub>GS</sub> = - 10 V	V <sub>DS</sub> = - 20 V, I <sub>D</sub> = - 10 A	P-Ch	-	5.5	-	
	Q <sub>gd</sub>	V <sub>GS</sub> = 10 V	$V_{DS} = 20 \text{ V}, I_D = 10 \text{ A}$	N-Ch	-	4.8	-	1
Gate-Drain Charge <sup>c</sup>		V <sub>GS</sub> = - 10 V	V <sub>DS</sub> = - 20 V, I <sub>D</sub> = - 10 A	P-Ch	-	10.5	-	1
		40			2.0	4.11	6.2	+
Gate Resistance	Rg		f = 1 MHz	N-Ch P-Ch	3.1	6.3	9.5	Ω
					U. 1	0.0	0.0	Ь

#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.



SPECIFICATIONS (T <sub>C</sub> = 2	25 °C, unless o	otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS			TYP.	MAX.	UNIT	
Turn-On Delay Time <sup>c</sup>		$\begin{aligned} V_{DD} &= 20 \text{ V}, \text{ R}_L = 2 \Omega \\ I_D &\cong 10 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega \end{aligned}$	N-Ch	-	7	11		
	t <sub>d(on)</sub>	$V_{DD} =  20 \text{ V},  R_L = 2  \Omega$ $I_D \cong  10  A,  V_{GEN} =  10  V,  R_g = 1  \Omega$	P-Ch	-	11	17	- ns	
Diag Time <sup>C</sup>		$\begin{aligned} V_{DD} &= 20 \text{ V}, \text{ R}_L = 2 \Omega \\ I_D &\cong 10 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega \end{aligned}$	N-Ch	-	21	32		
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} =  20 \text{ V},  R_L = 2  \Omega$ $I_D \cong  10  A,  V_{GEN} =  10  V,  R_g = 1  \Omega$	P-Ch	-	9	14		
Turn-Off Delay Time <sup>c</sup>		$\begin{aligned} V_{DD} &= 20 \text{ V}, \text{ R}_L = 2 \Omega \\ I_D &\cong 10 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega \end{aligned}$	N-Ch	-	33	50		
	t <sub>d(off)</sub>	$V_{DD} =  20 \text{ V},  R_L = 2  \Omega$ $I_D \cong  10  A,  V_{GEN} =  10  V,  R_g = 1  \Omega$	P-Ch	-	55	83		
Fall Time <sup>c</sup>		$\begin{aligned} V_{DD} &= 20 \text{ V}, \text{ R}_L = 2 \Omega \\ I_D &\cong 10 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega \end{aligned}$	N-Ch	-	19	29		
	t <sub>f</sub>	$\begin{aligned} V_{DD} = -20 \text{ V, } R_L = 2  \Omega \\ I_D \cong -10 \text{ A, } V_{GEN} = -10 \text{ V, } R_g = 1  \Omega \end{aligned}$	P-Ch	-	91	137		
Source-Drain Diode Ratings and	d Characteristics	b						
Pulsed Current <sup>a</sup>	I <sub>SM</sub>		N-Ch	-	-	32	A	
	ISM		P-Ch	-	_	- 32		
Forward Voltage	Van	I <sub>S</sub> = 4 A	N-Ch	-	0.79	1.2	V	
Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 4 A	P-Ch	-	- 0.82	- 1.2	] v	

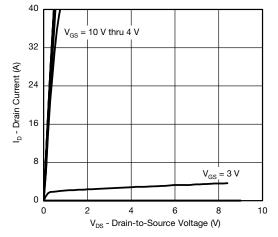
### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

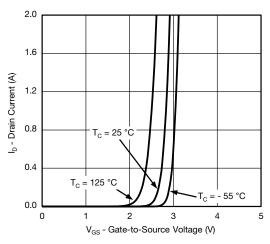
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



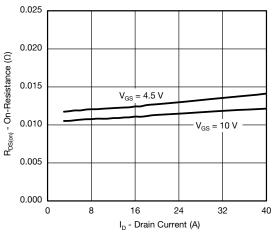
# **N-CHANNEL TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)



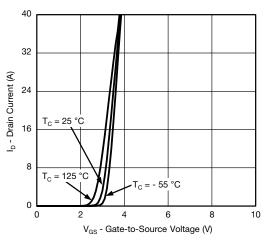
### **Output Characteristics**



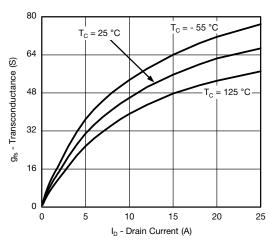
#### **Transfer Characteristics**



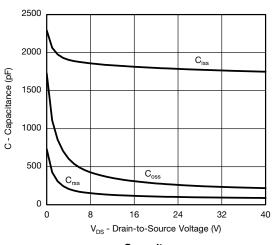
On-Resistance vs. Drain Current



**Transfer Characteristics** 



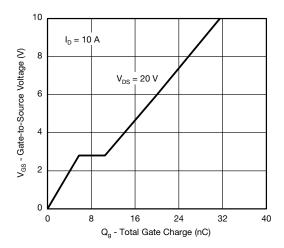
Transconductance



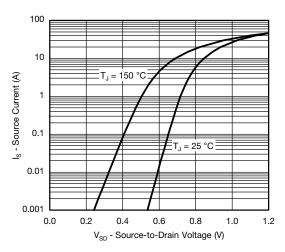
Capacitance



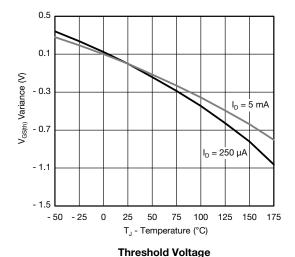
# **N-CHANNEL TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)

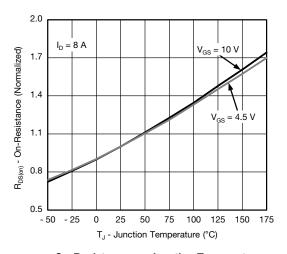


### **Gate Charge**

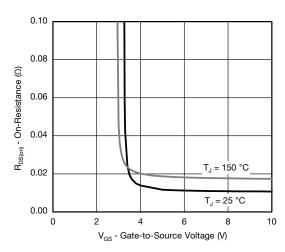


**Source Drain Diode Forward Voltage** 

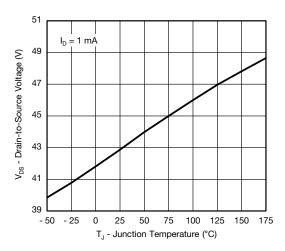




On-Resistance vs. Junction Temperature



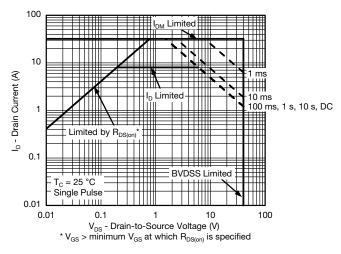
On-Resistance vs. Gate-to-Source Voltage



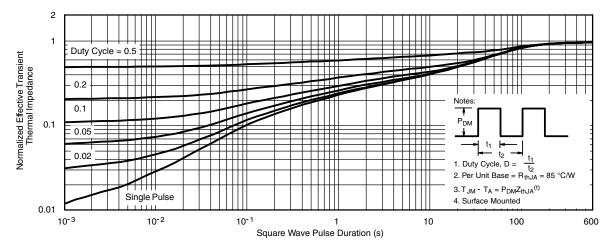
**Drain Source Breakdown vs. Junction Temperature** 



# **N-CHANNEL TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)

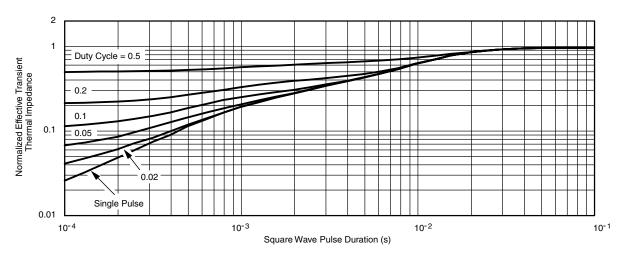


Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient

## N-CHANNEL TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, unless otherwise noted)



#### Normalized Thermal Transient Impedance, Junction-to-Case

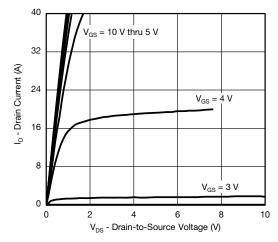
#### Note

- The characteristics shown in the two graphs
- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

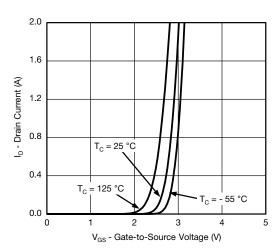
are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



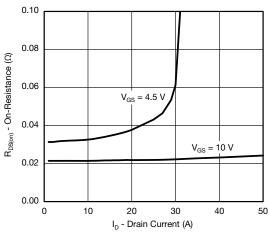
# **P-CHANNEL TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)



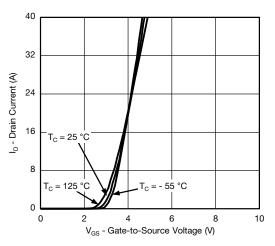
### **Output Characteristics**



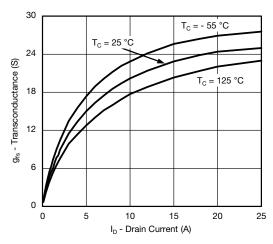
**Transfer Characteristics** 



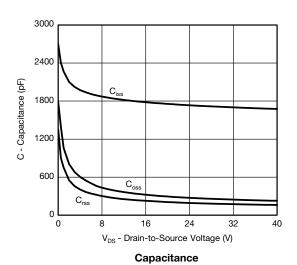
On-Resistance vs. Drain Current



**Transfer Characteristics** 

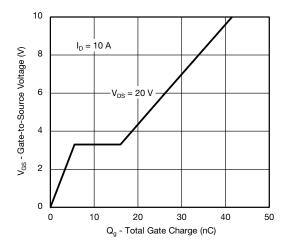


Transconductance

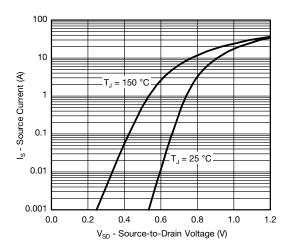




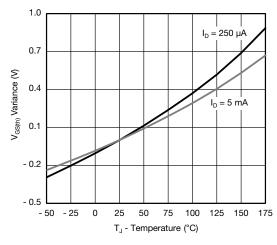
# **P-CHANNEL TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)



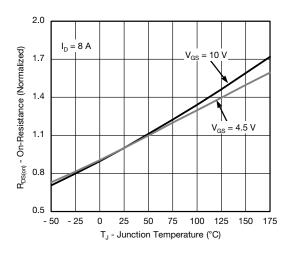
### **Gate Charge**



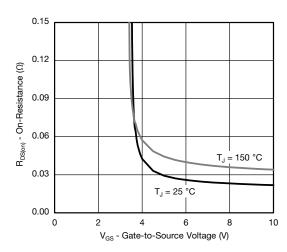
### **Source Drain Diode Forward Voltage**



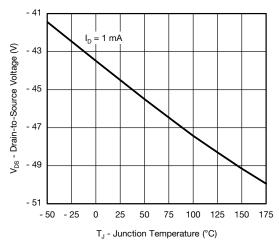
**Threshold Voltage** 



On-Resistance vs. Junction Temperature



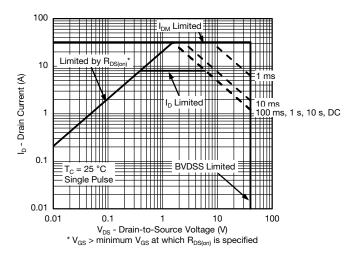
On-Resistance vs. Gate-to-Source Voltage



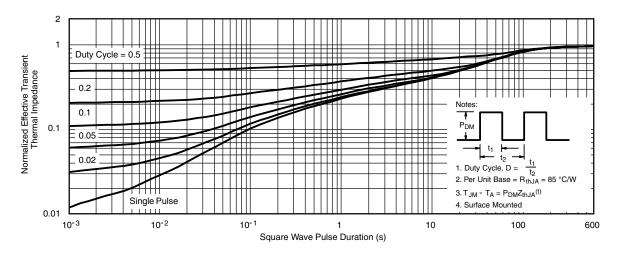
**Drain Source Breakdown vs. Junction Temperature** 



# **P-CHANNEL TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)

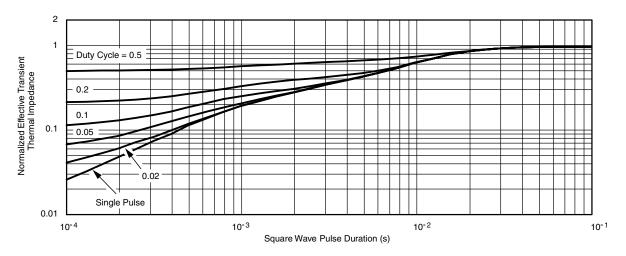


### Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient

## P-CHANNEL TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, unless otherwise noted)



#### Normalized Thermal Transient Impedance, Junction-to-Case

#### Note

- The characteristics shown in the two graphs
- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?67517">www.vishay.com/ppg?67517</a>.





Vishay

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